REASUNES

N Channel MOSFET

Applications:

- •Adapter & Charger
- •SMPS Standby Power
- •AC-DC Switching Power Supply
- •LED driving power

Features:

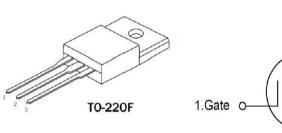
- •Low On Resistance
- •Low Gate Charge
- •Peak Current vs Pulse Width Curve
- •RoHS Compliant

🗭 Lead

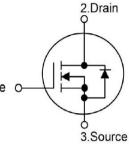
Lead Free Package and Finish

RS8N80F

ID	RDS(ON)(Typ.)	Vdss
8. 0A	1.42Ω	800V



Not to Scale



Ordering Information

Part Number	Package	Marking
RS8N80F	T0-220F	RS8N80F

Absolute Maximun Ratings Tc=25°C unless otherwise specified

Symbol	Parameter	RS8N80F	Units
VDSS	Drain-to-Source Voltage (Note*1)	800	V
ID	Continuous Drain Current	8.0	
ID@ 100 °C	Continuous Drain Current	5.1	А
IDM	Pulsed Drain Current (Note*2)	32.0	
DD	Power Dissipation	57	W
PD	Derating Factor above 25℃	0.46	₩/°C
VGS	Gate-to-Source Voltage	± 30	V
EAS	Single Pulse Avalanche Engergy L=30mH IAS=5.5A VDD=135V RG=25Ω TJ=25℃	534	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	°C
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

*Drain Current Limited by Maximum Junction Temperature

Caution:Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.

Thermal Resistance

Symbol	Parameter	RS8N80F	Units	Test Conditions
Rejc	Junction-to-Case	2.19	°C/W	Drain lead soldered to water cooled heatsink,PD adjusted for a peak junction temperature of +150°C.
Rөja	Junction-to-Ambient	120		1 cubic foot chamber, free air.

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain-to-source Breakdown Voltage	800			V	V _{GS} =0V, I _D =250µA
IDSS	Drain-to-Source Leakage Current		-	1.0	μĄ	VDS=800V, VGS=0V
T	Gate-to-Source Forward Leakage	1		100		VGS=+30V VDS=0V
IGSS	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} =-30V V _{DS} =0V

OFF Characteristics TJ=25°C unless otherwise specified

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS (on)	Static Drain-to-Source On-Resistance		1.42	1.6	Ω	VGS=10V, ID=4. 0A
Vgs (TH)	Gate Threshold Voltage	2.0		4.0	V	VGS=VDS, ID=250µA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn-on Delay Time		30.33	-		VDS=400V ID=8.0A RG=25Ω (Note:3,4)
trise	Rise Time		67.00	-		
td(OFF)	Turn-OFF Delay Time		58.00		nS	
tfall	Fall Time		38.33			

Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		1083		pF	$V_{GS}=0V$ $V_{DS}=25V$ f=1.0MHz
Coss	Output Capacitance		103			
Crss	Reverse Transfer Capacitance		5.8			
$Q_{ m g}$	Total Gate Charge		24.62			VDS=640V ID=8.0A VGS=10V (Note:3,4)
Q_{gs}	Gate-to-Source Charge		7.26		nC	
Qgd	Gate-to-Drain("Miller") Charge		8.97			



Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
Is	Continuous Source Current			8.0	А	Integral pn-diode
ISM	Maximum Pulsed Current			32.0	А	in MOSFET
Vsd	Diode Forward Voltage		-	1.4	V	Is=8. 0A, Vgs=0V
trr	Reverse Recovery Time		310.00		nS	V _{GS} =0V
$Q_{ m rr}$	Reverse Recovery Charge		0.53		μC	Is=8.0A, di/dt=100A/µs

Notes:

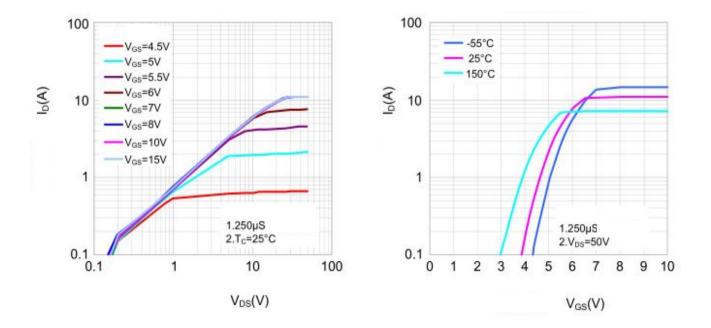
*1.TJ=±25℃ to +150℃.

- *2. Repetitive rating; pulse width limited by maximum junction temperature.
- *3. Pulse width \leq 300 μ s; duty cycle \leq 2%.
- *4. Basically not affected by temperature.

Typical Feature curve

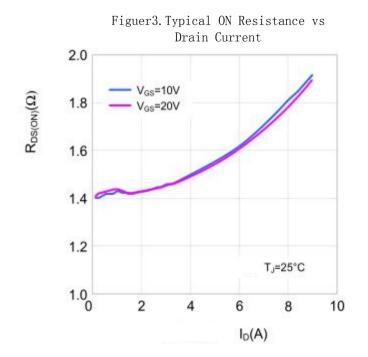
Figure1. Typical Output Characteristics

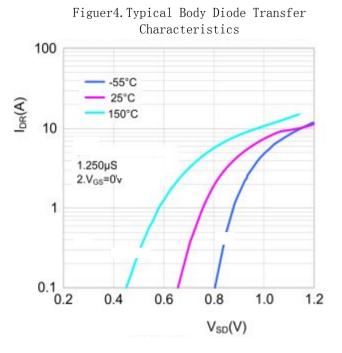
Figure2. Typical Transfer Characteristics

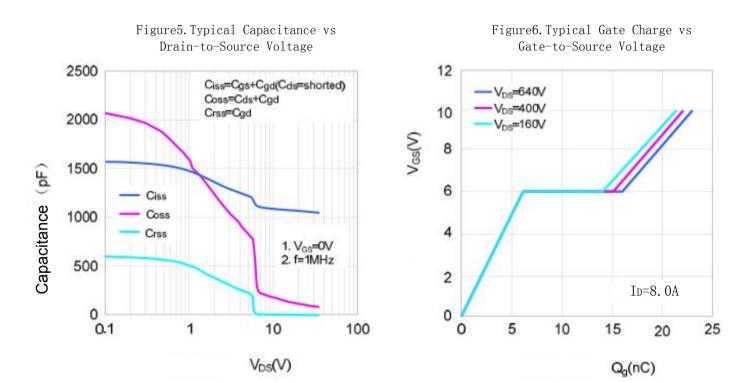


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RS8N80F







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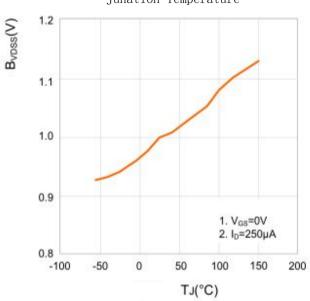


Figure7. Typical Breakdown Voltage vs

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Junation Temperature R_{DS(ON)}(Ω 3.0 2.5 2.0 1.5 1.0

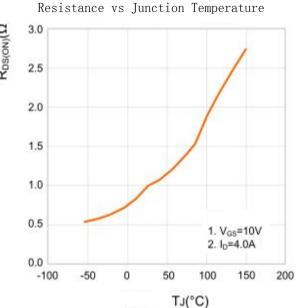
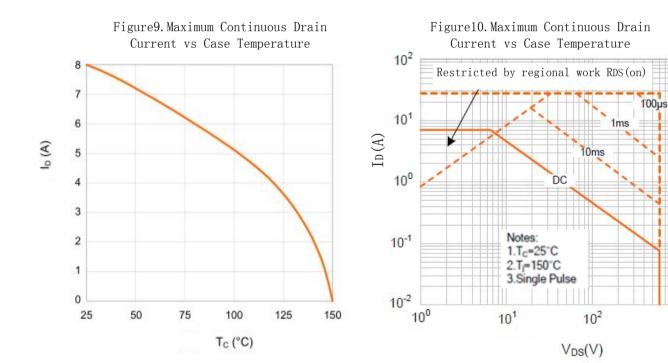


Figure8. Figure10. Typical Drain-to-Source ON



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 10^{3}



Test Circuits and Waveforms

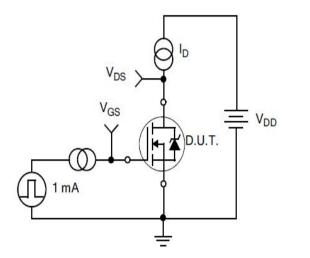


Figure11. Gate Charge Test Circuit



VDS

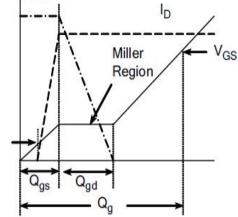


Figure12. Gate Charge Waveform

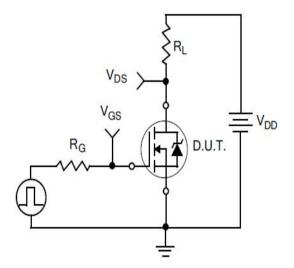
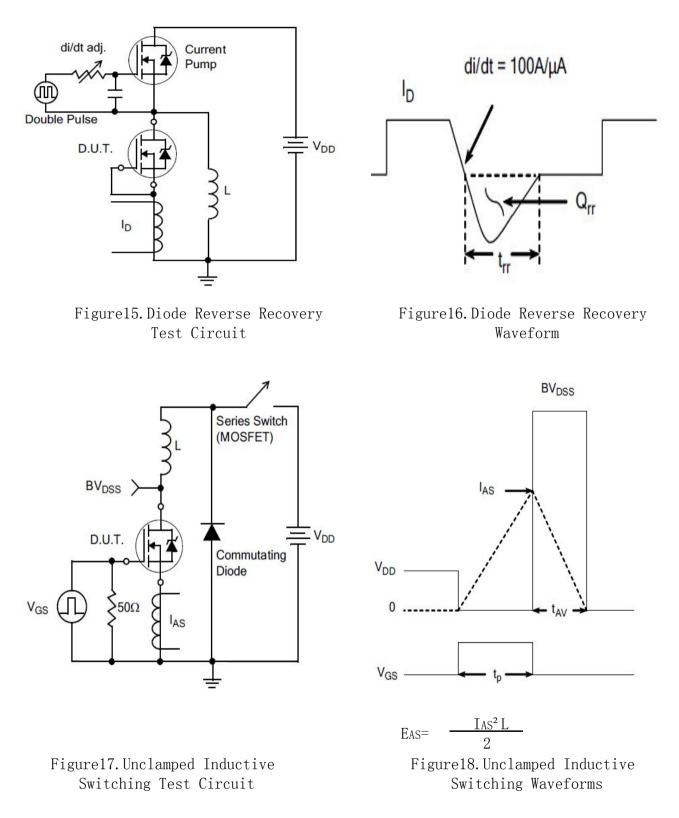


Figure13. Resistive Switching Test Circuit

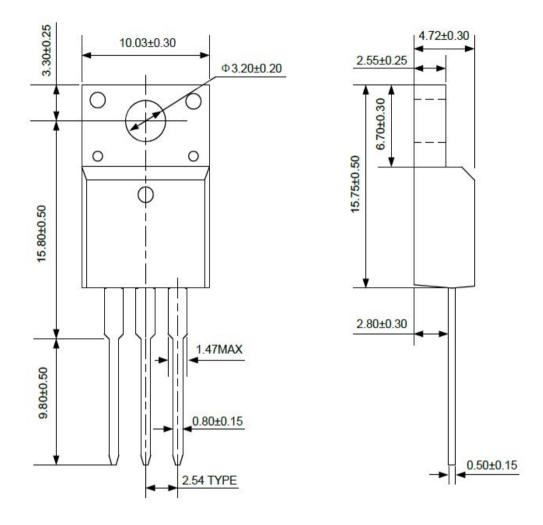
Figure14. Resistive Switching Waveforms



Test Circuits and Waveforms



Package outline drawing



T0-220F



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